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Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/017,722	SUN, SHIJUN	
Examiner	Art Unit	
David H. Malzahn	2193	

SEARCHED			
Class	Subclass	Date	Examiner
708	402	7/6/2005	DHM
382	250	7/6/2005	DHM
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
708	402	7/6/2005	DHM
382	250	7/6/2005	DHM

SEARCH N (INCLUDING SEARC	IOTES CH STRATEGY	)
	DATE	EXMR
None	7/6/2005	DHM
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